

Search Notes**Application/Control No.**

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Examiner

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**Applicant(s)/Patent under
Reexamination**

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Art Unit

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SEARCHED

Class	Subclass	Date	Examiner
708	320, 819	12/29/2010	MAI

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Data Bases Search (see search history printout(s))	12/29/2010	MAI